



# P-Channel 30 V (D-S) MOSFET

PRODUC	PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
- 30	0.020 at V <sub>GS</sub> = - 10 V	- 12 <sup>a</sup>	15.5 nC			
- 30	0.033 at V <sub>GS</sub> = - 4.5 V	- 12 <sup>a</sup>	15.5110			

### **FEATURES**

 Halogen-free According to IEC 61249-2-21 Definition



- New Thermally Enhanced PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Package
  - Small Footprint Area
  - Low On-Resistance
  - Thin 0.8 mm profile

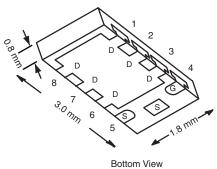
APPLICATIONSLoad Switch

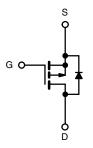
Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN FREE

#### PowerPAK® ChipFET® Single





P-Channel MOSFET

Ordering Information: Si5419DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30	V	
Gate-Source Voltage		$V_{GS}$	± 20		
	T <sub>C</sub> = 25 °C		- 12 <sup>a</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	- 12 <sup>a</sup>		
Continuous Brain Current (1) = 100 O)	T <sub>A</sub> = 25 °C	] 'U [	- 9.9 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	- 7.9 <sup>b, c</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	- 40		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		- 12 <sup>a</sup>		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	Is	- 2.6 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		31		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	20	w	
Maximum rower bissipation	T <sub>A</sub> = 25 °C	] 'b [	3.1 <sup>b, c</sup>	• • • • • • • • • • • • • • • • • • • •	
	T <sub>A</sub> = 70 °C	1	2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RAT	MAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	34	40	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	3	4	O/ VV	

### Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile (<a href="www.vishay.com/ppg?73257">www.vishay.com/ppg?73257</a>). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 30			٧
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 20		14/00
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		5		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 1.2		- 2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zawa Cata Waltana Duain Courset	1	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 V$ , $V_{GS} = -4.5 V$	- 20			Α
Durin Course On Olate Benintania	Б	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 6.6 A		0.016	0.020	0
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5.1 A		0.027	0.033	Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 6.6 A		20		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			1400		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		240		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			200		
Total Gata Chargo	Qg	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 9.9 A		30	45	nC
Total Gate Charge				15.5	24	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -9.9 \text{ A}$		4.5		
Gate-Drain Charge	$Q_{gd}$			7.5		
Gate Resistance	$R_g$	f = 1 MHz		6.7		Ω
Turn-on Delay Time	t <sub>d(on)</sub>			47	70	
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 1.9 \Omega$		33	50	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -7.9 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		30	45	
Fall Time	t <sub>f</sub>			16	25	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 1.9 \Omega$		10	15	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -7.9 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		40	60	
Fall Time	t <sub>f</sub>			12	20	
Drain-Source Body Diode Characterist	cs					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 12	А
Pulse Diode Forward Current	I <sub>SM</sub>				40	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 7.9 A, V <sub>GS</sub> = 0 V		- 0.85	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	40	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			15	25	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -7.9 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °\text{C}$		11		200
Reverse Recovery Rise Time	t <sub>b</sub>	]		14		ns

#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

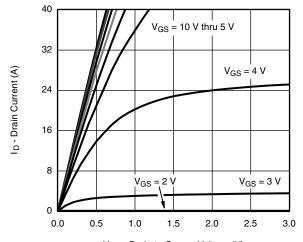
a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$ 

a. Guaranteed by design, not subject to production testing.



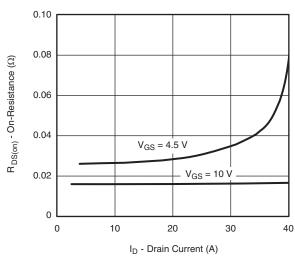


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

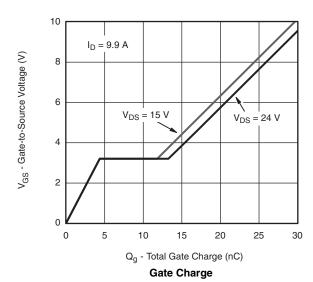


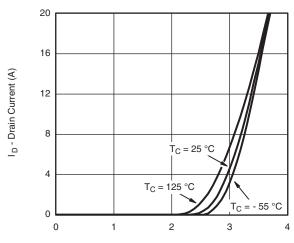
 $V_{\text{DS}}$  - Drain-to-Source Voltage (V)

#### **Output Characteristics**



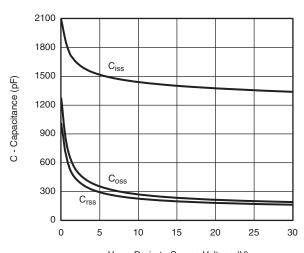
### On-Resistance vs. Drain Current





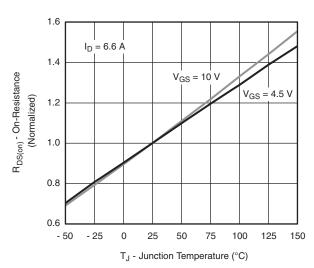
V<sub>GS</sub> - Gate-to-Source Voltage (V)

#### Transfer Characteristics



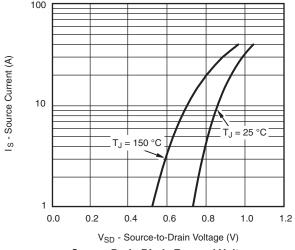
 $V_{\mbox{\footnotesize DS}}$  - Drain-to-Source Voltage (V)

### Capacitance

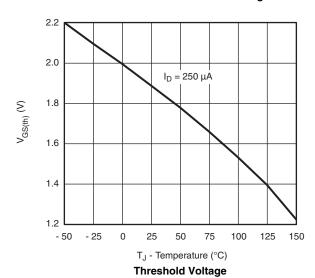


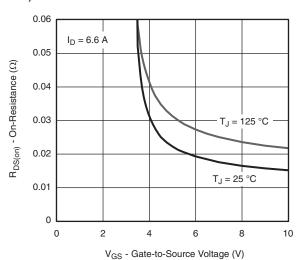
On-Resistance vs. Junction Temperature

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

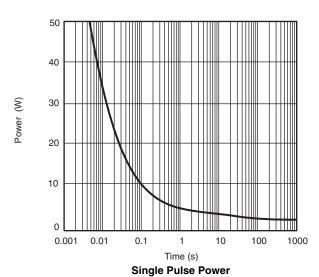


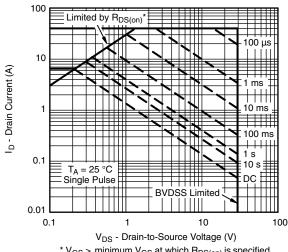






On-Resistance vs. Gate-to-Source Voltage





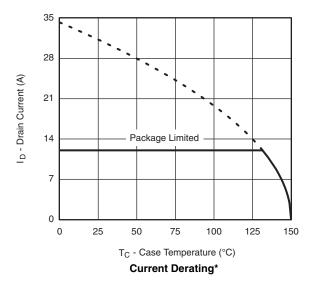
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

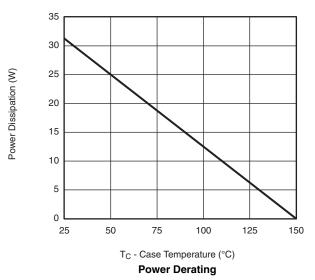
Safe Operating Area





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

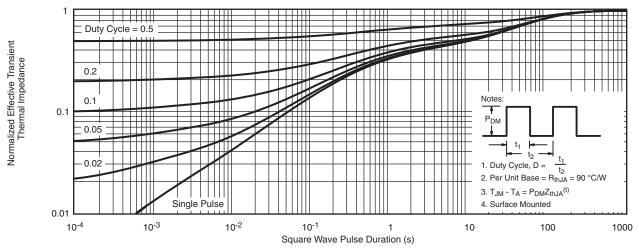




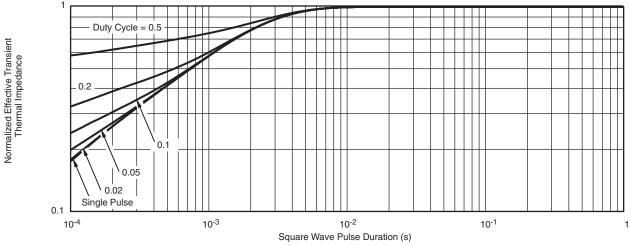
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

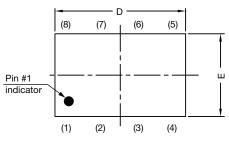


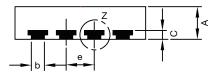
Normalized Thermal Transient Impedance, Junction-to-Case

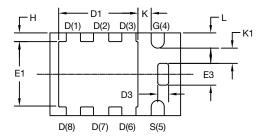
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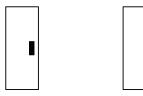
# PowerPAK® ChipFET® Case Outline







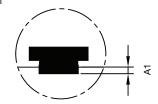
Backside view of single pad



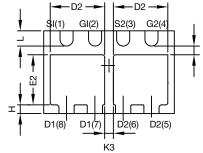
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.85	0.028	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D1	1.75	1.87	2.00	0.069	0.074	0.079	
D2	1.07	1.20	1.32	0.042	0.047	0.052	
D3	0.20	0.25	0.30	0.008	0.010	0.012	
Е	1.82	1.90	1.98	0.072	0.075	0.078	
E1	1.38	1.50	1.63	0.054	0.059	0.064	
E2	0.92	1.05	1.17	0.036	0.041	0.046	
E3	0.45	0.50	0.55	0.018	0.020	0.022	
е		0.65 BSC		0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010	
K	0.25	-	-	0.010	-	-	
K1	0.30	-	-	0.012	-	-	
K2	0.20	-	=	0.008	-	-	
K3	0.20	-	-	0.008	-	-	
L	0.30	0.35	0.40	0.012	0.014	0.016	

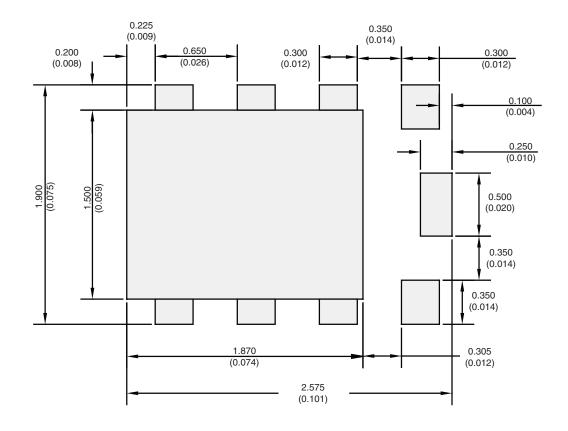
#### C14-0630-Rev. E, 21-Jul-14 DWG: 5940

Note

• Millimeters will govern



# RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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Vishay

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